



### III. VIRTUAL CMM SYSTEM

#### A. Control System

The Virtual CMM System consists of Control System and the Entity of the CMM. And the Control System is the core of the simulation.

The major function of the Control System is to analyse CNC codes, including G codes, M codes, etc.

Some of the codes could be used directly for inspection simulation, such as “G00” for moving the virtual CMM to the exact point swiftly. However, traditional G codes could not meet the requirements of some inspection features such as holes. To inspect the feature such as a hole, the coordinates and the vector of the hole-centre and the radius of the hole would be given, and by analysing these statistics, the CMM could accomplish the measurement of a hole. So a development of the Control System is necessary and important.

#### B. Entity of CMM

The modelling accuracy of the virtual CMM’s entity determines the precision of the simulation. There are two ways to modelling the entity. One is mapping and the other one is by parametric modelling of the Pro/E.

Build three-dimensional simulation model of the CMM entity by CAD software such as Pro/E or CATIA. Export the models in the format of .stl. Create a new project of virtual CMM in VERICUT and import the .stl models. Add five axis X, Y, Z, A, C in the new virtual CMM. Associate the models with the axis and set the motion modes of the axis. Establish the coordinate system of the virtual CMM and set the collision detection, travel limits and the initial position of the CMM. The process is shown in Figure 2.

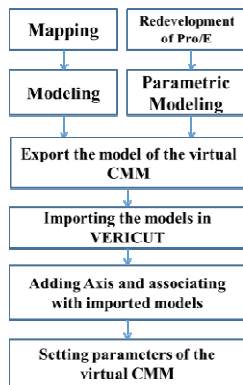


FIGURE II. PROCESS OF CMM’S ENTITY BUILDING.

#### C. Probe Library

The establishment of the probe library is based on the tool library of VERICUT. The file of the tool library is according to the rule of Xml which could be revised and edited. All of the information including the length, diameter, clamping points of the probe was recorded in this file. By resolving the file, the parameters of the probe could be defined and new probes could be built.

The probe library could be visited by the inspectors via the interfaces. The whole process is shown in figure 3.

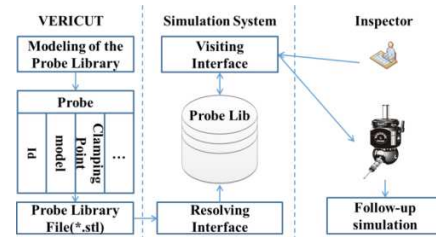


FIGURE III. PROCESS OF VISITING PROBE LIBRARY.

### IV. GENERATION OF THE SIMULATION PROGRAM

#### A. Swing Angle

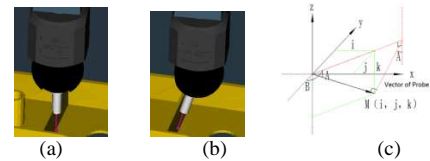


FIGURE IV. SWING ANGLE COMPUTATION.

In order to avoid the interference to the most extent, a series of rational swing angles would be computed. As is shown in Figure4, the swing angle in (b) is much more proper than the one in (a).

In figure 4(c),  $M(i, j, k)$  is the vector of the measurement point and the vector of probe should be perpendicular to  $M$ . The angle between the vector of probe and Z-axis negative is defined as angle A, and the angle between the vector of probe in the projection of the XY plane and Y-axis negative is defined as angle B.

The calculation of angle A and angle B could be described as eqn (1) and eqn (2).

$$A = [(\arccos(k) \cdot \frac{180}{\pi} - 90) |15] \cdot 15 \quad (1)$$

$$B = \left[ \left( \pm 90 + \arctan\left(\frac{j}{i}\right) \cdot \frac{180}{\pi} \right) |15 \right] \cdot 15 \quad (2)$$

#### B. Points Array

According to the measurement points and position points obtained from the Xml, arrange the points in a certain order to form the simulation points array.

If the path contains only one feature to inspect, one measurement point has only one position point to match. But if there are more than one feature to inspect, more position points are required as the safety position points so as to avoid collision when crossing the features.

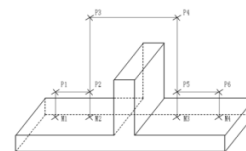


FIGURE V. EXAMPLE OF POINTS ARRAY.

In figure 5,  $M_i$  are the measurement points and  $P_i$  are the position points, the simulation points array are:

P1→M1→P1→P2→M2→P2→P3→P4→P5→  
M3→P5→P6→M4

### C. Simulation Program

The simulation program is formed based on the simulation points array and the format that the control system could be resolved. Two kinds of programs are formed. One is the main program and the other is subprogram. Main program is generated according to the simulation points array. And subprogram is generated based on the specific feature such as a hole and the control system.

The process of simulation programming is shown in Figure 6.

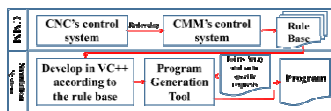


FIGURE VI. PROCESS OF SIMULATION PROGRAMMING.

## V. CASE STUDY

The CMM simulation system in Fig (a) was developed by MFC. An Xml file named IP Xml which was generated by CAIP system would be imported. After importing this file, all of the paths in this file would be traversed. By choosing the corresponding path, the inspection items would be listed on the right. The name and path of the program should be given by the inspector. Then the parameters of the probe should be set. Eventually, the program would be generated.

After opening VERICUT and configuring the environment of the virtual CMM system, the program would be loaded. Then press start button and the simulation program would be executed.

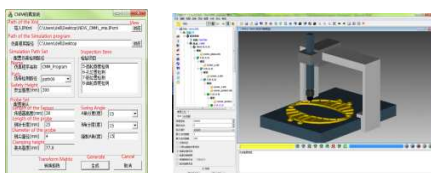


FIGURE VII. CASE STUDY.

## VI. CONCLUSION

In this paper, a new train of thought in inspection simulation was raised on the platform of VERICUT, which is one of the most common CNC simulation software. A CMM simulation system was established, where the Xml file generated by CAIP system was analysed and a CMM simulation program which could be loaded by VERICUT was generated. By building a virtual CMM system in VERICUT according to the actual measurement environment, the inspecting process could be simulated accurately by running the program.

## REFERENCES

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